Modulation of nitrogen vacancy charge state and fluorescence in nanodiamonds using electrochemical potential

Sinan Karaveji, Ophir Gaathon, Abraham Wolcott, Reyu Sakakibara, Or A. Shemesh, Darcy S. Peterka, Edward S. Boydene, Jonathan S. Owen, Rafael Yuste, and Dirk Englund.

Department of Electrical Engineering and Computer Science, Massachusetts Institute of Technology, Cambridge, MA 02139; Department of Electrical Engineering, Columbia University, New York, NY 10027; Diamond Nanotechnologies, Inc., Boston, MA 02134; Department of Chemistry, Columbia University, New York, NY 10027; MIF Media Laboratory, Massachusetts Institute of Technology, Cambridge, MA 02139; McGovern Institute for Brain Research, Massachusetts Institute of Technology, Cambridge, MA 02139; Department of Biological Sciences, Columbia University, New York, NY 10027; Department of Brain and Cognitive Sciences, Massachusetts Institute of Technology, Cambridge, MA 02139; and Department of Biological Engineering, Massachusetts Institute of Technology, Cambridge, MA 02139

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The negatively charged nitrogen vacancy (NV−) center in diamond has attracted strong interest for a wide range of sensing and quantum information processing applications. To this end, recent work has focused on controlling the NV charge state, whose stability strongly depends on its electrostatic environment. Here, we demonstrate that the charge state and fluorescence dynamics of single NV centers in nanodiamonds with different surface terminations can be controlled by an externally applied potential difference in an electrochemical cell. The voltage dependence of the NV charge state can be used to stabilize the NV− state for spin-based sensing protocols and provides a method of charge state-dependent fluorescence sensing of electrochemical potentials. We detect clear NV fluorescence modulation for voltage changes down to 100 mV, with a single NV and down to 20 mV with multiple NV centers in a wide-field imaging mode. These results suggest that NV centers in nanodiamonds could enable parallel optical detection of biologically relevant electrochemical potentials.

Significance

The nitrogen vacancy center in diamond is a fluorescent color center that can be in several charge states depending on its local electrostatic environment. Here, we demonstrate the control of the charge state and fluorescence of NVs in nanodiamonds (NDs) by applying a potential difference across NDs in an electrochemical cell. Controlling the charge state can improve spin-based sensing protocols of the NV. Conversely, the NV's strong fluorescence dependence on electrochemical potential differences also enables a new modality for optical sensing of its environment. With this electrochemical setup, we show that a single NV can reveal a 100-mV potential swing, whereas multiple NVs allow for the detection of potential swings as small as 20 mV.


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1S.K. and O.G. contributed equally to this work.

2Present address: Department of Chemistry, San Jose State University, San Jose, CA 95192.

3To whom correspondence should be addressed. Email: englund@mit.edu.

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Understanding these relationships would be of great use for de-
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surface, the varying crystallographic orientations on individual sur-
graphic (20, 21), and superresolution localization (22
the crystallographic orientation of diamond (gray shaded region). Equilibration
strongly negative electron affinity, whereas hydroxyl (OH) surface termination
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the biocompatibility of NDs (26) combined with the exceptional
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NV
In contrast to bulk diamond, NDs can be deployed into various
applications (25, 27–29). To this end, we show below that the NV charge state and fluo-
cent imaging (Materials and Methods). The coverslips were
with different surface termination. The NV centers were excited, and their fluorescence signal was collected through the ITO-covered coverslip using a high numerical aperture (NA = 1.4) 100x oil objective. A potentiostat was used to apply a potential difference (Ψ_{app} = Ψ_{w} − Ψ_{ref}) between the ITO working electrode (Ψ_{w}) and the Ag/AgCl reference electrode (Ψ_{ref}) immersed in an aqueous electrolyte solution. This applied potential drops across the electric-double layer formed at the ITO/electrolyte interface where the NDs are located. The applied potential changes the band bending inside the NDs and varies the energy separation between the Fermi level (E_F) and the NV charge state transition levels (E_{NV+/0} and E_{NV−/−}). This energy variation can be strong enough to shift the E_{NV+/0} below or above E_F and cause switching of the NV charge state (SI Text).
We used this apparatus to study the voltage-dependent charge state and fluorescence dynamics of two types of NDs: hydroxyl-
ated NDs with primarily hydroxyl surface termination groups and hydroxidated NDs with primarily hydrogen surface termination groups with mean sizes of 18 and 12 nm, respectively (Materials and Methods and SI Text) (30).

Fig. 2A shows a wide-field fluorescence image of hydroxidated NDs on the ITO working electrode under 532-nm excitation. The image was acquired using a 650-nm long-pass (LP) filter to preferentially detect NV− fluorescence. We applied triangular voltage sweeps between +0.75 and −0.75 V (Fig. 2B, Upper) while acquiring wide-field images with 100-ms exposure on an electron multiplying charge coupled device (emCCD) camera. From this series of images, we extracted the photoluminescence (PL) time traces of each fluorescent spot (Materials and Methods). Fig. 2B shows the PL recordings of the three characteristic spots highlighted in Fig. 2A. Individual traces are shown in the panel on the left, and voltage-cycle averaged PL traces (solid lines) with their SD (shaded region) are plotted on the right. From the cycle-averaged PL, we calculated the maximum PL modulation (ΔF_{max}) and SD (F_{std}) for each spot. From these measurements, we determined the fraction of NVs with significant modulation, defined as ΔF_{max}/F_{std} > 1.5. Of ~4,300 NDs measured on multiple samples, 21% satisfied this metric of voltage-dependent PL modulation (Fig. 2C). The PL response is not uniform, but varies for different NDs. This nonuniform behavior is clear from the PL traces for the three sites shown in Fig. 2B: the PL of spots A and B increase at negative voltages, whereas the PL of spot C shows the opposite voltage dependence. To study this variation of PL modulation, we categorized the cycle-averaged PL into eight distinct types (types 1–8) shown on the left panel of Fig. 2D. The distribution of the subsets of NDs that exhibited voltage dependence is shown in Fig. 2D. Approximately 94% of detected spot PL modulation (types 1–3) were out of phase with respect to the applied potential and showed an increase in PL at negative potential differences, whereas 5% showed inphase response (types 4–6). Some spots exhibited a PL change that was independent of the voltage polarity (types 7 and 8).

To investigate the role of the charge state in the PL modulation, we studied isolated NDs exhibiting single NV fluorescence, as determined by separate photon anti-bunching measurements showing g^2(0) < 0.5 (SI Text). The cycle-averaged PL response of such a single NV is shown in Fig. 3A. This NV center exhibited the most common type 2 PL modulation, with a PL increasing

Fig 1. NV fluorescence and experimental setup schematic. (A) Fluorescence emission spectra of neutrally (blue) and negatively (red) charged NV centers in HPHT NDs. (Inset) Illustration of the NV center in the diamond lattice. (B) Energy band structure schematic showing the band bending near hy-
hydrogen (H) and hydroxyl (OH) surface terminated di-

diamond in atmospheric conditions. Hydrogen surface termination results in a
strongly negative electron affinity, whereas hydroxyl (OH) surface termination
can have a range of both positive or negative electron affinity depending on the
crystallographic orientation of diamond (gray shaded region). Equilibration
of the Fermi level (E_F) with the redox couple of a surface adsorbate layer in-
duces the band bending, shifting the conduction (CBM), and valence (VBM) bands
together with the NV charge state transition levels E_{NV−/−} (red) and E_{NV+/0} (blue). Close to the surface, these transition levels can move above E_F (light red and blue lines) and result in a change in the NV charge state depending on their
distance to the surface. (C) Schematic of the electrochemical setup used to apply
voltages while monitoring the ND fluorescence.

similar techniques can also be applied to NVs in nanodiamonds
(NDs). NDs present a more complex environment for NVs than the bulk crystal. Complexities include the NV’s distance to the
surface, the varying crystallographic orientations on individual sur-
faces, and the heterogeneity of functional groups. As a result of the
complex energy structure of any given ND and the inhomogeneity
between different NDs, it is difficult to predict how an NV’s charge
state responds to external fields, local charges, and voltage variations.
Understanding these relationships would be of great use for de-
veloping new sensing applications using fluorescent NDs.

In contrast to bulk diamond, NDs can be deployed into various
systems, such as cells and biological tissues, for imaging and sensing
applications, including thermometry (19), particle tracking in vivo
(20, 21), and superresolution localization (22–24). Here, we report
on the charge state and fluorescence dynamics of NV centers in
NDs located on the working-electrode/electrolyte interface of an
electrochemical cell. By varying the potential difference applied
across the NDs, it is possible to modulate the NV charge state and
fluorescence properties. We also show that this effect depends
strongly on the ND chemical surface termination. The ability to
control the NV charge state could improve spin-based sensing
applications (19, 20, 23, 25). Moreover, the charge state-dependent
fluorescence offers a previously unidentified technique for sensing
the NV’s local electrochemical environment. One promising appli-
cation may be the detection of neuronal action potentials. Indeed,
the biocompatibility of NDs (26) combined with the exceptional
brightness and photostability of NV centers have motivated great
interest in voltage imaging and biolabeling applications (25, 27–29).

Results and Discussion
Fig. 1C shows the experimental apparatus. An electrochemical
cell consisting of an indium-tin-oxide (ITO)-coated coverslip is
positioned on an inverted microscope for wide-field or scanning
confocal imaging (Materials and Methods). The coverslips were
coated with NDs with different surface termination. The NV
centers were excited, and their fluorescence signal was collected

Materials and Methods

Methods

D

Fig. 2 shows the PL recordings of the three characteristic
spots highlighted in Fig. 2A. Individual traces are shown in the
panel on the left, and voltage-cycle averaged PL traces (solid
lines) with their SD (shaded region) are plotted on the right.

From this series of images, we extracted the photoluminescence
(PL) time traces of each fluorescent spot (Materials and Methods).

Fig. 2B shows the PL recordings of the three characteristic
spots highlighted in Fig. 2A. Individual traces are shown in the
panel on the left, and voltage-cycle averaged PL traces (solid
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From this series of images, we extracted the photoluminescence
(PL) time traces of each fluorescent spot (Materials and Methods).

Materials

Methods
24% as the potential difference, $\Psi_{app}$, was lowered from 0 to $-0.75$ V. Fig. 3B shows the PL spectra for $\Psi_{app}$ equal to 0 (blue line) and $-0.75$ V (red line), acquired with the confocal setup (Materials and Methods). The spectra of single NVs typically reflect rapidly switching NV$^0$ and NV$^-$ charge states (5, 6). For $\Psi_{app}=0$ V, the NV’s fluorescence spectrum exhibits dominant (75%) NV$^0$ emission with a 25% NV$^-$ contribution, as estimated from a fit (SI Text) to the NV$^{-}$ and NV$^0$ spectra shown in Fig. 1A. The NV$^-$ contribution increases to 45% at $-0.75$ V. The shaded region in Fig. 3B shows the difference between the two spectra above 650 nm. This difference corresponds to an increase of 31% above 650 nm, which approximately matches the 24% increase observed from the wide-field measurements (Fig. 3A). We conclude that for hydroxylated NDs, the voltage-dependent PL is primarily due to shifting of NV$^0$ and NV$^-$ charge state distributions.

The change in the NV charge state can be qualitatively described by band bending due to electric field across the ND. Even without any applied external bias, the potential difference between the ITO and the Ag/AgCl electrodes due to their work function differences leads to the formation of a built-in electric field at the ITO/electrolyte interface. For the NV center in the hydroxylated ND shown in Fig. 3, this built-in electric field results in the $E_{NV\infty}$ level being slightly below $E_F$ and the NV primarily in the neutral charge state. The applied potential difference changes the electric field across the ND. This variation induces further band bending that reduces the energy separation between $E_{NV\infty}$ and $E_F$ at the position of the NV center, resulting in an increased probability of the NV$^0$ to be in the negative charge state. The results shown in Figs. 2 and 3 indicate that for the majority of modulating NVs, lowering the potential of the ITO electrode with respect to the reference electrode increases the NV$^-$ contribution (modulation types 1–3). We attribute this imbalance in the voltage dependence to the built-in potential difference at the ITO/electrolyte interface. The distribution within the modulation types 1–3 is likely to be due to variations in the NV$^0$’s location in the ND and the ND’s shape. The band bending at the NV’s exact location depends on its distance to the surface, resulting in a range of responses to the same applied potential difference.

To investigate the influence of surface termination on the voltage-dependent ND PL, we repeated the above described experiments using NDs with hydrogenated surfaces (Materials and Methods and SI Text). Consistent with previous results of NVs near hydrogen-terminated surfaces (8), the PL of these NDs show dominantly NV$^0$ emission due to the increase in the near-surface band bending. A 562-nm long-pass filter was used to detect changes in the NV$^0$ fluorescence. The results, summarized in Fig. 4, were analyzed in the same manner as for the hydroxylated NDs (Fig. 2). Fig. 4B shows the PL for the three representative fluorescent spots indicated in Fig. 4A as $\Psi_{app}$ is swept between $+0.5$ and $-0.5$ V. Remarkably, of the $\sim 1,200$ distinct NDs measured across multiple samples, 89% showed an above-threshold PL...
modulation (Fig. 4C): a much larger percentage than for the hydroxylated NDs. In addition, these NDs also show a larger voltage dependence with a normalized PL ($\Delta F_{\text{mod}}/F_{\text{mean}}$) of up to 110% for a potential range of 0.75 to $-0.75\ V$ (SI Text). Moreover, the modulation characteristics (Fig. 4D) are more uniform (types 1–3) than for the hydroxylated NDs (Fig. 2D). This greater uniformity would be beneficial for sensing applications.

Fig. 4A shows the average PL change as a function of $\Psi_{\text{app}}$ for an isolated hydrogenated ND containing a single NV center, as confirmed again by anti-bunching measurements (SI Text). As $\Psi_{\text{app}}$ is increased, the NV PL drops, corresponding to modulation type 3 shown in Fig. 4. We also performed spectral measurements for an average $\Psi_{\text{app}}$ of 125 and 375 mV, shown in the red and blue lines in Fig. 5B. The fluorescence spectra only show NV$^+$ emission and negligible contribution from NV$^-$. The observed decrease in NV$^+$ could be either due to an increase in the nonradiative decay rate of the NV center or due to the switching of the NV center from the fluorescent NV$^+$ to a nonfluorescent dark state that is commonly attributed to the NV$^-$ charge state (14–16). A change in nonradiative decay rate would result in a change of NV excited state lifetime. However, we did not observe a significant change in fluorescence lifetime due to $\Psi_{\text{app}}$ (SI Text). Therefore, we conclude that the PL variation is due to switching between the bright NV$^+$ and the dark NV$^-$ charge states with $\Psi_{\text{app}}$. Within the band bending picture, this indicates that applying a positive potential to the ITO increases band bending and pushes the $E_{\text{NV}}^-$ level further above $E_F$.

We attribute the significant increase in the number of NV centers that show voltage-dependent PL in hydrogenated NDs to two effects: the large band-bending induced by hydrogen surface termination and the conductive properties of hydrogenated diamond surface. The NV charge state is determined by the position of the charge state transition levels $E_{\text{NV}}^+$ and $E_{\text{NV}}^-$ with respect to $E_F$ inside the diamond. Hydrogen termination of the ND surfaces results in a stronger band bending compared with hydroxyl termination. The increased band bending accounts for the greater fraction of NV$^+$ centers in hydrogen terminated diamond (Fig. 1B). The increase in the number of modulating NV centers therefore suggests that the average energy difference between $E_{\text{NV}}^+$ and $E_F$ in hydroxylated NDs is larger than the average energy difference between $E_{\text{NV}}^+$ and $E_F$ in hydrogenated NDs. Thus, a larger external potential difference would be required to perturb the NV charge state in the hydroxylated NDs compared with hydrogenated NDs. Furthermore, unlike hydroxyl terminated diamond, hydrogen terminated diamond surfaces are conductive due to the formation of a surface hole accumulation layer (8). Consequently, charge transfer between the ITO electrode and hydrogenated NDs’ surface could occur. Such charge transfer to localized surface states would change the ND surface.
potential and affect the near-surface band bending. In addition, charging of the ND can also alter the Fermi level in the ND. Both of these effects will strongly influence the energy difference between $E_{\text{v}}$, and $E_F$, and thus NV’s charge state, which could result in an increased percentage of NVs demonstrating voltage-dependent PL.

To investigate the possibility of charge transfer, we repeated the wide-field measurements in Figs. 2 and 4 on ITO electrodes with a 5-nm-thick coating of alumina (Al$_2$O$_3$) acting as a spacer between the ITO and the NDs (Materials and Methods and SI Text). For hydroxylated NDs, we observe a decrease, from 23% to 13%, in the number of NVs showing voltage-dependent PL, whereas for hydrogenated NDs, we observe a drastic decrease, from 89% to ∼1% (SI Text). These findings suggest that there are two different mechanisms by which the applied potential difference can modulate the charge state of the NV. For the hydroxylated NDs, the persistence of PL modulation in the presence of the alumina spacer suggests that the charge state modulation results from band-bending induced by the electric field generated by the potential difference across the ND. A similar electric field-induced effect has previously been observed in NV centers under the insulating regions of an in-plane field effect diamond device (15). However, for the hydrogenated NDs, almost no modulation was observed when the conductive diamond surface was not in direct electrical contact with the ITO electrode. This lack of modulation indicates that for hydrogenated NDs, band bending induced by charge transfer to the ND surface is the dominant mechanism by which the applied potential difference modulates the NV charge state. Although electric field-induced band bending could also occur for hydrogenated NDs on the alumina spacer layer, our results suggest that screening of the electric fields by the conductive surface surrounding the NDs reduces this effect.

The sensitivity of the NV charge state and PL to external fields and potential changes could enable applications for sensing the local electrochemical environment, e.g., for neuronal voltage imaging. For hydroxylated NDs, the electric field due to the ∼100-mV variation in the neuron cell membrane potential could induce changes to the NV’s charge state and result in detectable PL modulation. One possible complication for this application is that the potential away from the cell membrane is rapidly screened due to the nanometer-scale Debye length in biological media. This challenge may be mitigated by using small (∼5–15 nm) NDs embedded inside the membrane. Our results indicate that the fluorescence of hydrogenated NDs is not directly sensitive to external electric fields but instead requires charge transfer to the ND surface to induce band bending, in agreement with previous studies on hydrogen terminated bulk diamond. Functionalizing the ND surface with charged molecules or polymers could provide a mechanism for such charge transfer. For example, it has been shown that electrical activity in cells can be detected by the use of voltage-dependent charge transfer from molecular wires to a fluorescent reporter (31, 32). Functionalizing hydrogenated NDs with similar molecular wires could provide the necessary charge movement and allow their use as voltage indicators. To gauge the expected performance of both hydroxylated and hydrogenated NDs, we tested their PL response to biologically relevant potential fluctuations at timescales that approach action potential in mammalian neurons using wide-field fluorescence imaging. Fig. 6A shows the PL intensity trace for two separate single NV centers in the hydroxylated NDs acquired with a camera exposure time of 100 ms. Both NVs exhibited clear PL modulation as a function of $\Psi_{\text{app}}$. We observed the strongest PL response when a bias voltage of ∼400 mV was applied to the modulation signal (see SI Text for the statistical distribution of DC bias point at which each NV showed the highest PL response). We also performed similar experiments on hydrogenated NDs. Because hydrogenated NDs are hydrophobic, they formed agglomerates on the hydrophilic ITO surface. Therefore, diffraction limited spots of hydrogenated NDs typically contained multiple NDs and NV centers, improving the signal to noise ratio of the measurement. Consequently, we were able to observe a clear PL response from individual clusters for voltage pulses as short as 5 ms and amplitude variations as small as 100 mV with a 2-ms camera exposure time (Fig. 6B). Shorter voltage pulses could not be detected due to the large RC time constant (∼30 ms) of the large surface area electrochemical cells used in this study. The time traces shown in Fig. 6A and B are for individual fluorescent spots of NDs, with the green PL trace in Fig. 6A corresponding to the same single NV center as in Fig. 3. By integrating the PL signal of 12 distinct fluorescent spots across the image, 20-mV signals were detectable with a 35-ms exposure time (Fig. 6C).

Compared with optical voltage indicators that broadly stain cell membranes, sparse ND-based indicators could enable voltage recording from single subdiffraction limited sites and reduced background (33). In addition to the NV center, numerous other fluorescent defect centers in diamond and other semiconductor materials (e.g., SiC) have been investigated for quantum information and sensing applications (12, 34, 35). Such fluorescent defects can be stable in ultrasmall crystals: the SiV$^-$ has been observed in NDs as small as 1.6 nm in diameter (36). Many of these fluorescent defects are likely to also exhibit charge state and fluorescence modulation via the electrochemical environment.

In summary, we demonstrated the modulation of the charge state and fluorescence of NV centers in NDs in an electrochemical cell. The NV fluorescence response depends strongly on the ND surface termination, which affects both the underlying mechanism and the overall fraction of modulating NVs. For hydroxylated NDs, we observed shifting between the NV$^0$ and NV$^-$ charge states. This charge state variation is attributed to changes in electric field induced band-bending inside the diamond in response to an applied potential difference. On the other hand, for hydrogenated NDs, we observe shifting of the NV charge state between NV$^0$ and a nonfluorescent state. We attribute this switching mechanism to charge transfer between the NDs and the ITO.

**Fig. 6.** Detection of small voltage variations. (A) PL time traces of two isolated hydroxylated NDs to 100-mV voltage changes. (B) PL time trace of a hydrogenated ND cluster to 5-ms, 100-mV square voltage pulses. (C) PL time trace of multiple ND clusters to 20-mV voltage changes.

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electrode. Our results suggest the utility of NV-NDs for fluorescence-based sensing of electrochemical potential changes. Because of the strong PL modulation, which can be as high as $\Delta F = 110\%$, it is possible to observe electric potential variations of 100 mV even with a single NV emitter. By collecting signal from several NVs, the detection of potential changes as low as 20 mV and a setup-limited temporal response down to 5 ms was achievable. This strong dependence of the NV charge state to the electrochemical environment promises an optical nanometer-scale sensing modality for the physical and life sciences.

Materials and Methods

Electrochemical Cell. ITO-coated coverslips (30–60 $\Omega$ sq; SPI Supplies) were cleaned with acetone, isopropl alcohol, and oxygen plasma. A cylindrical polypropylene tube was subsequently epoxied onto the ITO coverslip. This electrochemical cell contained ~750 $\mu$L electrolyte at room temperature. The solution was deoxygenated with high-purity nitrogen gas and was maintained all day. The cell was equipped with a potentiostat (CH Instruments; 630D) in a three-electrode setup consisting of the ITO working electrode, a platinum wire (CH Instruments) counter electrode, and a leak-free reference electrode (Harvard Apparatus). The aluminia (Al$_2$O$_3$)-coated ITO working electrode was fabricated by deposition of 5 nm alumina with atomic layer deposition.

Experimental Setup. The experiments were performed on an inverted microscope (Zeiss Axiosvert 200M) equipped with an immersion oil objective (Zeiss Planapochromat 100x NA = 1.4). For wide-field fluorescence measurements, a 300-mW, 532-nm continuous wave (CW) laser was focused to the back aperture of the objective to illuminate an ~42-$\mu$m-diameter area on the electrochemical cell. The fluorescence signal from NV centers was collected with the same objective, filtered using either a 562- or 650-nm long-pass filter, and directed to an emCCD camera (Photometrics Cascade 1k, Photometrics 128+). The voltage-dependent PL recordings of each fluorescent spot were obtained by the analysis of the wide-field measurements using custom MATLAB routines. Confocal measurements were performed with a home-built laser scanning microscopy setup implemented on the side port of the same microscope. In short, the 532-nm excitation laser focused to a diffraction limited spot was scanned on the sample surface using two galvanometer mirrors located on a plane conjugate to the microscope objective back aperture. The fluorescence signal was collected with the same path, spectrally filtered with either a 550-nm long-pass or a 550- to 600-nm band-pass filter, and imaged on a single mode optical fiber connected to a single avalanche photodiode (APD) or spectrometer. Spectral measurements were performed by connecting the collection fiber to a grating spectrometer (SP2500; Princeton Instruments) equipped with a CCD camera (PIXIS 1024B; Princeton Instruments). Note that the fast oscillations observed in the spectra shown in Figs. 1A, 3B, and 5B are due to the etaloning effect on the CCD camera.

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Supporting Information

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SI Text

Band Bending-Induced NV Charge State Shifting in NDs. Previous work by Grotz et al. (14) investigated variations of the charge state of NV centers located near the surface of a bulk diamond in contact with an electrolyte. This study used numerical modeling using the nextnano numerical simulation package, which can self-consistently solve for the coupled Schrödinger-Poisson equation (37, 38). We used the same software package to calculate the energy band structure of the ITO/ND/electrolyte system and to investigate how a potential difference applied between the ITO working electrode and the reference electrode affects the band bending inside the ND and the NV charge state. Specifically, we performed 2D simulations of an I8-mm ND in contact with an ITO working electrode (modeled as a metal) and surrounded by an electrolyte (Fig. S1A). The simulation parameters for the diamond are as follows (14): T = 298 K; diamond band gap = 5.47 eV; valence band mass = 2.18, 0.7, and 0.06 meV nitrogen concentration = 100 ppm; NV

-band state transition level, \( E_{NV^-} = 2.8 \) eV + \( E_F \) electrolyte = 10 mM phosphate buffer with 100 ppm; NV

and NV

E

is above 10 mM phosphate buffer with 100 ppm; NV

(blue lines, reaches 0.27 and 0.17, respectively, for 0 and 0.5 V from 1,360 to 1,500 cm

= -π/1o f7 from 1,360 to 1,500 cm

and NV

shows the total count rate on both APDs while the \( \Psi_{app} \) is varied between the low PL state at 0V (red) and the high PL state at -0.75V (blue). To compensate for sample drift, the confocal spot was readjusted every 60 s to the maximal PL signal position, which resulted in the PL dips observed in the middle of each voltage cycle. The second-order autocorrelation results \([g^{(2)}(\tau)]\) obtained from the photon arrival times for the two different \( \Psi_{app} \) values are shown in Fig. S4B without background subtraction. The results show the anti-bunching at zero delay and bunching at short delay times typically observed for NV centers. Most importantly, the anti-bunching dip at \( g^{(2)}(0) \) reaches 0.27 and 0.17, respectively, for 0 and -0.75 V. The \( g^{(2)}(0) < 0.5 \) shows that the PL signal is due to a single NV center and that an additional emitter is not being turned on or off due to the applied potential difference.

As discussed in the main text, we recorded the PL spectrum of an NV center in a hydroxylated ND for two different \( \Psi_{app} \) values (Fig. 3). The single NV center’s spectrum exhibited PL signal from both NV0 and NV-. To quantify the PL contribution from each NV charge state, we fit the PL spectra at each \( \Psi_{app} \) (blue lines, Fig. S5) to a linear superposition of the NV0 and NV- spectra shown in Fig. 4A using \( I_F = (1 - \rho)I_{NV^0} + \rho I_{NV^-} \). From these fits (red lines) we deduce that the NV- contribution, \( \rho \), increases from \( \sim 25\% \) at 0 V (Fig. SS4) to \( \sim 45\% \) at -0.75 V. We notice that the position of the NV0 zero-phonon-line (ZPL) acquired at the two voltages does not match that of the reference spectrum perfectly. Furthermore, the ZPL shifts from 575.9 nm at 0 V (Fig. SS4) to 577.6 nm at -0.75 V (Fig. SSB), which is indicative of a large DC Stark shift. To first order, the linear Stark shift of an electronic transition (\( \Delta \nu \)) due to a local electric field (\( F \)) is given by \( h \Delta \nu = -\Delta \mu \cdot F \). Although there has been no systematic study of DC Stark shift of the NV0 ZPL, studies on NV+ have obtained \( \Delta \mu \) of up to 1.5 Debye. Assuming that the NV0 would exhibit a similar dipole moment change, the 1.7-nm ZPL shift we observe indicates a local electric field on the order of 106 V/m. This value is on the same order of magnitude as the electric field due to the electrochemically applied potential change of 0.75 V dropping over a Debye length of \( \sim 1-10 \) nm.

Single NV in Hydrogenated ND. Fig. 5B shows the PL spectra for a single NV0 center in a hydrogenated ND. The single emitter nature of the NV center was confirmed by second-order autocorrelation measurements (Fig. S6C). The applied potential difference (\( \Psi_{app} \)) affects the NV0 PL intensity only, and no contribution from the NV- state is observed. The change in the NV0 PL can be attributed to the transition of the NV center from the neutral NV0 to the nonfluorescent positively charged NV+
state that has been recently reported in bulk diamond (14, 15). Another potential cause of the PL modulation in hydrogenated NDs is the voltage-dependent variations on the nonradiative decay processes. For a single emitter, the PL intensity is directly proportional to the quantum efficiency (QE), which depends on the radiative ($k_R$) and nonradiative ($k_{NR}$) decay rates: 

$$PL \propto QE = \frac{k_R}{k_R + k_{NR}}.$$ 

Consequently, an increase in the nonradiative decay rate would result in reduced PL intensity. Variations in the nonradiative decay rate would also result in different excited state lifetimes ($\tau$) as $\tau^{-1} = k_R + k_{NR}$. We performed time-resolved PL measurements on the NV$^0$ fluorescence to obtain the lifetime at different $\Psi_{app}$ values. To this end, the NV center was excited using a pulsed supercontinuum laser (superK Extreme; NKT Photonics) whose output was filtered with a 10-nm band-pass filter centered at 532 nm. The 78-MHz pulse repetition rate was reduced to 13 MHz using an electro-optic modulator-based pulse picker setup. Periodic square-wave voltage pulses of 0.5 V were applied (Fig. S6A), whereas the PL signal from NV$^0$ was detected with a single APD and time-tagged with respect to the laser pulse using a time-correlated single photon counting system (PicoHarp 300). The time-tagged photons arrival events were then used to obtain both the PL count rate (Fig. S6B) and PL decay traces (Fig. S6D). The PL decay traces were fit to a single exponential decay, $I(t) = I_0 \exp(-t/\tau) + C$, to obtain the excited state lifetime. Fig. S6D shows two PL decay traces obtained at 0 (red) and +0.5 V (blue). The corresponding fits (dashed lines) show that the lifetime stays constant at ∼27 ns, even though the PL count rate decreases as seen in Fig. S6B. This constant lifetime indicates that nonradiative decay processes do not play a significant role in the voltage-dependent PL. We thus conclude that the PL variation is due to switching between the fluorescent NV$^0$ and the nonfluorescent NV$^+$ charge states.

**Voltage-Dependent PL Statistics.** We observed variations in the voltage-dependent PL modulation for both hydroxylated and hydrogenated NDs. From wide-field measurements (similar to Figs. 2 and 4), we obtain the PL recordings as a function of the applied potential difference for each fluorescent spot. To this end, the NV center was excited using a pulsed supercontinuum laser (superK Extreme; NKT Photonics) whose output was filtered with a 10-nm band-pass filter centered at 532 nm. The 78-MHz pulse repetition rate was reduced to 13 MHz using an electro-optic modulator-based pulse picker setup. Periodic square-wave voltage pulses of 0.5 V were applied (Fig. S6A), whereas the PL signal from NV$^0$ was detected with a single APD and time-tagged with respect to the laser pulse using a time-correlated single photon counting system (PicoHarp 300). The time-tagged photons arrival events were then used to obtain both the PL count rate (Fig. S6B) and PL decay traces (Fig. S6D). The PL decay traces were fit to a single exponential decay, $I(t) = I_0 \exp(-t/\tau) + C$, to obtain the excited state lifetime. Fig. S6D shows two PL decay traces obtained at 0 (red) and +0.5 V (blue). The corresponding fits (dashed lines) show that the lifetime stays constant at ∼27 ns, even though the PL count rate decreases as seen in Fig. S6B. This constant lifetime indicates that nonradiative decay processes do not play a significant role in the voltage-dependent PL. We thus conclude that the PL variation is due to switching between the fluorescent NV$^0$ and the nonfluorescent NV$^+$ charge states.

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Fig. S1. Numerical simulation result of the energy band diagram of the ITO/nanodiamond/electrolyte system. 2D map of the valence band maxima for (A) 0, (B) +0.5, and (C) −0.5 V. The regions for which $E_{\text{N}V} < E_F$ are highlighted in green. (D) Energy band diagram of the cross-section highlighted in A for the three applied potential differences.

Fig. S2. FTIR spectra of (A) the hydroxylated nanodiamonds and (B) hydrogenated nanodiamonds. (A) (O-H) modes on the diamond surface are observed at 2,700–3,500 cm$^{-1}$ due to adsorbed water, whereas the (O-H), can be seen at 1,640 cm$^{-1}$. The (C = O) mode at 1,780 cm$^{-1}$ and (C-O), at 1,100 cm$^{-1}$ is still observed due to acids and alcohols. (B) (C-H) modes on the ND surface are observed at 2,800–2,900 cm$^{-1}$, whereas the (C-H), can be seen at 1,350–1,500 cm$^{-1}$. The (C-O), mode at 1,100 cm$^{-1}$ is still observed due to alcohols, whereas a sharp mode at 1,260 cm$^{-1}$ is believed to be (C = C).
Fig. S3.  (A) Histograms of the diameters of the two types of HPHT NDs used in this study. The histograms were generated from size measurements of TEM images taken from each sample. The hydrogenated NDs have size of 12 ± 5 nm and the hydroxylated NDs have a size of 18 ± 8 nm, based on a 100 ND ensemble. The size was estimated from the TEM analysis with a spherical particle shape model as described in the procedure. (B) A representative TEM image.

Fig. S4.  (A) Fluorescence time trace measurements for the same NV center for a rectangular voltage signal acquired with a fiber-based confocal HBT setup. (B) Second-order autocorrelation result obtained from the analysis of photon arrival times at two different \( \Psi_{\text{app}} \) values shown in A.
Fig. S5. Fitting of the PL spectra at 0 (A) and −0.75 V (B) to the linear combination of NV⁰ and NV⁻ reference spectra shown in Fig. 1.

Fig. S6. Single NV in hydrogenated nanodiamond lifetime analysis. Applied potential difference (A) and corresponding PL time traces (B) of a single NV center as determined from second-order autocorrelation measurements (C). PL decay traces (D) at 0 (red) and 0.5 V (blue) together with the instrument response function (IRF) and the fits to decay traces (dashed lines).
Fig. S7. Example cycle-averaged PL data as a function of time (A) and as function $\Psi_{app}$ (B).

Fig. S8. Statistical distribution of the modulation depth for each fluorescent spot for hydroxylated (red) and hydrogenated (blue) ND samples.
Fig. S9. Analysis of the distribution of the DC bias voltages for (A) hydroxylated and (B) hydrogenated NDs, together with the average $df/dV$ normalized to $F_0$ at each DC bias voltage value.

Fig. S10. Distribution of the maximum PL change ($\Delta F_{\text{max}}$) normalized to the SD of PL ($F_{\text{std}}$) for each measured fluorescent spot in (A) hydroxylated and (B) hydrogenated NDs on 5 nm $\text{Al}_2\text{O}_3$-coated ITO electrodes. (A) For hydroxylated NDs, 13% of 222 measured fluorescent spots showed PL change larger than $1.5 F_{\text{std}}$. (B) For hydrogenated NDs, 1.2% of 728 measured fluorescent spots showed PL change larger than $1.5 F_{\text{std}}$. 